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CONFIRMATION NO. 1659

Bib Data Sheet

SERIAL NUMBER 10/017,860	FILING DATE 12/14/2001 RULE	CLASS 073	GROUP ART UNIT 2863	ATTORNEY DOCKET NO. P989
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## APPLICANTS

David Adler, San Jose, CA;  
Kirk Bertsche, San Jose, CA;  
Mark McCord, Mountain View, CA;  
Stuart Friedman, Palo Alto, CA;

## \*\* CONTINUING DATA \*\*\*\*\*

THIS APPLN CLAIMS BENEFIT OF 60/256,168 12/15/2000

## \*\* FOREIGN APPLICATIONS \*\*\*\*\*

## IF REQUIRED, FOREIGN FILING LICENSE GRANTED

\*\* 02/22/2002

Foreign Priority claimed	<input type="checkbox"/> yes <input type="checkbox"/> no	STATE OR COUNTRY	SHEETS DRAWING	TOTAL CLAIMS	INDEPENDENT CLAIMS
35 USC 119 (a-d) conditions met	<input type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after Allowance	CA	26	48	17
Verified and Acknowledged	Examiner's Signature _____ Initials _____				

## ADDRESS

000031894

## TITLE

Method and apparatus for inspecting a substrate

FILING FEE RECEIVED 2550	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:	<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees ( Filing ) <input type="checkbox"/> 1.17 Fees ( Processing Ext. of time ) <input type="checkbox"/> 1.18 Fees ( Issue ) <input type="checkbox"/> Other _____ <input type="checkbox"/> Credit
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